

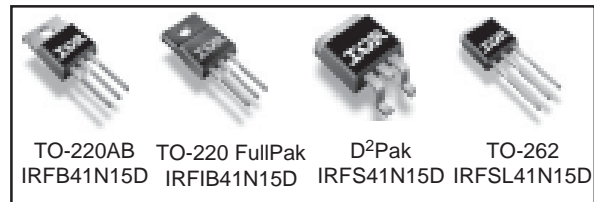
### Applications

- High frequency DC-DC converters
- Lead-Free

### Benefits

- Low Gate-to-Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective  $C_{OSS}$  to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current

$V_{DSS}$	$R_{DS(on)}$ max	$I_D$
150V	0.045Ω	41A



### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D$ @ $T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS}$ @ 10V	41	A
$I_D$ @ $T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS}$ @ 10V	29	
$I_{DM}$	Pulsed Drain Current ①	164	
$P_D$ @ $T_A = 25^\circ\text{C}$	Power Dissipation, D <sup>2</sup> Pak	3.1	W
$P_D$ @ $T_C = 25^\circ\text{C}$	Power Dissipation, TO-220	200	
$P_D$ @ $T_C = 25^\circ\text{C}$	Power Dissipation, Fullpak	48	
	Linear Derating Factor, TO-220	1.3	W/°C
	Linear Derating Factor, Fullpak	0.32	
$V_{GS}$	Gate-to-Source Voltage	± 30	V
dv/dt	Peak Diode Recovery dv/dt ③	2.7	V/ns
$T_J$	Operating Junction and	-55 to + 175	°C
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature, for 10 seconds		
	Mounting torque, 6-32 or M3 screw	1.1(10)	N•m (lb•in)

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	0.75	°C/W
$R_{\theta JC}$	Junction-to-Case, Fullpak	—	3.14	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface ④	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient, TO-220 ⑥	—	62	
$R_{\theta JA}$	Junction-to-Ambient, D <sup>2</sup> Pak ⑦	—	40	
$R_{\theta JA}$	Junction-to-Ambient, Fullpak	—	65	

Notes ① through ⑦ are on page 12

# IRFB/IRFIB/IRFS/IRFSL41N15DPbF

International  
**IR** Rectifier

## Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	150	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
ΔV <sub>(BR)DSS/ΔT<sub>J</sub></sub>	Breakdown Voltage Temp. Coefficient	—	0.17	—	V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance	—	—	0.045	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 25A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	3.0	—	5.5	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA
I <sub>DSS</sub>	Drain-to-Source Leakage Current	—	—	25	μA	V <sub>DS</sub> = 150V, V <sub>GS</sub> = 0V
		—	—	250		V <sub>DS</sub> = 120V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 150°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	—	—	100	nA	V <sub>GS</sub> = 30V
	Gate-to-Source Reverse Leakage	—	—	-100		V <sub>GS</sub> = -30V

## Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

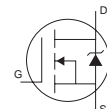
	Parameter	Min.	Typ.	Max.	Units	Conditions
g <sub>fs</sub>	Forward Transconductance	18	—	—	S	V <sub>DS</sub> = 50V, I <sub>D</sub> = 25A
Q <sub>g</sub>	Total Gate Charge	—	72	110	nC	I <sub>D</sub> = 25A V <sub>DS</sub> = 120V V <sub>GS</sub> = 10V ④
Q <sub>gs</sub>	Gate-to-Source Charge	—	21	31		
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge	—	35	52		
t <sub>d(on)</sub>	Turn-On Delay Time	—	16	—	ns	V <sub>DD</sub> = 75V I <sub>D</sub> = 25A R <sub>G</sub> = 2.5Ω V <sub>GS</sub> = 10V ④
t <sub>r</sub>	Rise Time	—	63	—		
t <sub>d(off)</sub>	Turn-Off Delay Time	—	25	—		
t <sub>f</sub>	Fall Time	—	14	—		
C <sub>iss</sub>	Input Capacitance	—	2520	—	pF	V <sub>GS</sub> = 0V V <sub>DS</sub> = 25V f = 1.0MHz V <sub>GS</sub> = 0V, V <sub>DS</sub> = 1.0V, f = 1.0MHz V <sub>GS</sub> = 0V, V <sub>DS</sub> = 120V, f = 1.0MHz V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 120V ⑤
C <sub>oss</sub>	Output Capacitance	—	510	—		
C <sub>rss</sub>	Reverse Transfer Capacitance	—	110	—		
C <sub>oss</sub>	Output Capacitance	—	3090	—		
C <sub>oss</sub>	Output Capacitance	—	230	—		
C <sub>oss eff.</sub>	Effective Output Capacitance	—	250	—		

## Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy ②	—	470	mJ
I <sub>AR</sub>	Avalanche Current ①	—	25	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①	—	20	mJ

## Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	41	A	MOSFET symbol showing the integral reverse p-n junction diode.
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	—	—	164		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.3	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = 25A, V <sub>GS</sub> = 0V ④
t <sub>rr</sub>	Reverse Recovery Time	—	170	260	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 25A
Q <sub>rr</sub>	Reverse Recovery Charge	—	1.3	1.9	μC	di/dt = 100A/μs ④
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

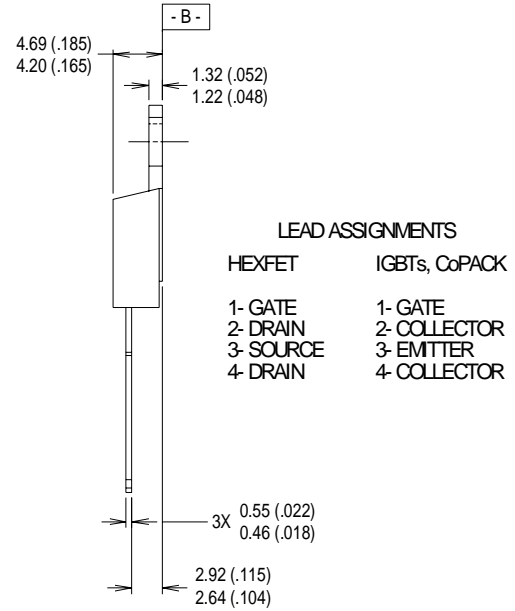
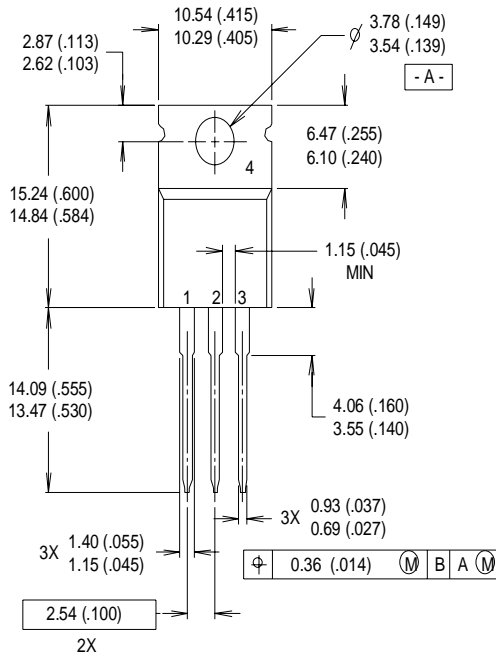


# IRFB/IRFIB/IRFS/IRFSL41N15DPbF

International  
**IR** Rectifier

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



**NOTES:**

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH
- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"  
**Note:** "P" in assembly line  
 position indicates "Lead-Free"

